

Silicon diffused power transistors

BU508AF; BU508DF

High-voltage, high-speed switching npn transistors in a fully isolated SOT199 envelope (with integrated efficiency diode for the BU508DF), primarily intended for use in horizontal deflection circuits of colour television receivers.

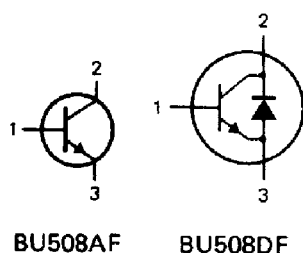
QUICK REFERENCE DATA

Collector-emitter voltage peak value; $V_{BE} = 0$ open base	V_{CESM}	max.	1500 V
	V_{CEO}	max.	700 V
Collector saturation current	I_{Csat}	max.	4,5 A
Collector current (DC)	I_C	max.	8 A
Collector current (peak value)	I_{CM}	max.	15 A
Total power dissipation up to $T_h = 25\text{ }^{\circ}\text{C}$	P_{tot}	max.	34 W
Collector-emitter saturation voltage	V_{CEsat}	max.	1 V
Diode forward voltage $I_F = 4,5\text{ A}$ (BU508DF)	V_F	typ.	1,6 V
Fall time	t_f	typ.	0,7 μs

MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT199.

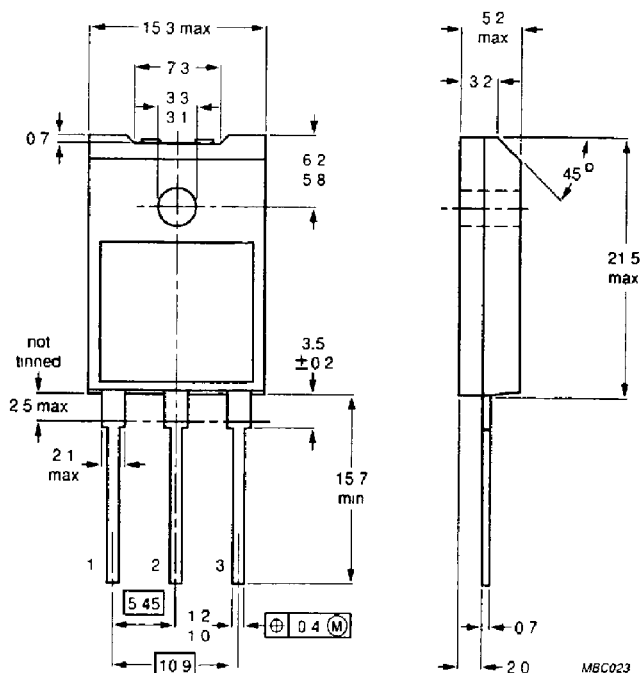


1 = base

2 = collector

3 = emitter

Mounting base is electrically
isolated from all terminals.



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RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage

peak value; $V_{BE} = 0$
open base

V_{CESM}	max.	1500 V
V_{CEO}	max.	700 V

Collector current

DC
peak value
saturation

I_C	max.	8 A
I_{CM}	max.	15 A
I_{Csat}	max.	4,5 A

Base current

DC
peak value

I_B	max.	4 A
I_{BM}	max.	6 A

Total power dissipation

up to $T_h = 25\text{ }^\circ\text{C}^*$

P_{tot}	max.	34 W
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Storage temperature

T_{stg}	-65 to + 150 $^\circ\text{C}$	
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Junction temperature

T_j	max.	150 $^\circ\text{C}$
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THERMAL RESISTANCE

From junction to mounting base

R_{thj-mb}	=	1 K/W
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From junction to external heatsink*

R_{thj-h}	=	3,7 K/W
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From junction to external heatsink**

R_{thj-h}	=	2,8 K/W
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From junction to ambient

R_{thj-a}	=	35 K/W
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ISOLATION

Isolation voltage from all terminals to
external heatsink (peak value)

V_{isol}	max.	1500 V
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Isolation capacitance from collector
to external heatsink

C_{isol}	typ.	21 pF
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CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

 $V_{CE} = V_{CESmax}; V_{BE} = 0$

I_{CES}	max.	1 mA
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 $V_{CE} = V_{CESmax}; V_{BE} = 0; T_j = 125\text{ }^\circ\text{C}$

I_{CES}	max.	2 mA
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Emitter cut-off current

 $V_{EB} = 6\text{ V}; I_C = 0$

I_{EBO}	max.	10 mA
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DC current gain

 $I_C = 100\text{ mA}; V_{CE} = 5\text{ V}$

h_{FE}	min.	6
h_{FE}	typ.	13
h_{FE}	max.	30

* Mounted without heatsink compound and 30 ± 5 newtons pressure on centre of envelope.** Mounted with heatsink compound and 30 ± 5 newtons pressure on centre of envelope.


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Saturation voltages

$I_C = I_{Csat}; I_B = 2\text{ A}$

Diode forward voltage

$I_F = 4,5\text{ A (BU508DF)}$

Collector-emitter sustaining voltage

$I_C = 0,1\text{ A}; I_B = 0; L = 25\text{ mH}$

V_{CEsat}	max.	1 V
V_{BEsat}	max.	1,3 V
V_F	max.	2 V
V_F	typ.	1,6 V
V_{CEOsus}	min.	700 V

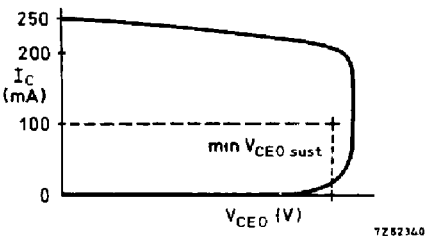


Fig. 2 Oscilloscope display for $V_{CEOsust}$.

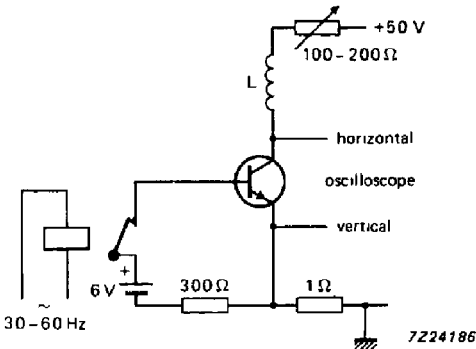


Fig. 3 Test circuit for $V_{CEOsust}$.

Second-breakdown current

$V_{CE} = 120\text{ V}; T = 200\text{ }\mu\text{s}$

Transition frequency at $f = 5\text{ MHz}$

$I_C = 0,1\text{ A}; V_{CE} = 5\text{ V}$

Collector capacitance at $f = 1\text{ MHz}$

$I_E = i_e = 0; V_{CB} = 10\text{ V}$

Switching times in horizontal deflection circuit

$-V_{IM} = 4\text{ V}; L_B = 6\text{ }\mu\text{H}$

$I_C = I_{Csat}; I_{B(end)} = 1,4\text{ A}$

$(-dI_B/dt = 0,6\text{ A}/\mu\text{s})$

I_{SB}	min.	11 A
f_T	typ.	7 MHz
C_C	typ.	125 pF
t_f	typ.	0,7 μs
t_s	typ.	6,5 μs

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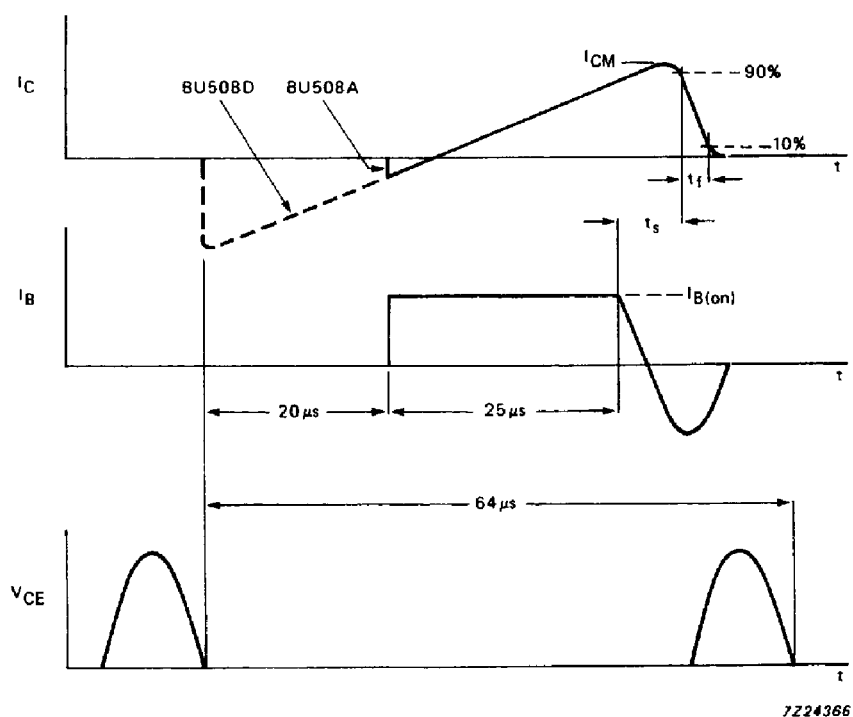


Fig. 4 Switching times waveforms.

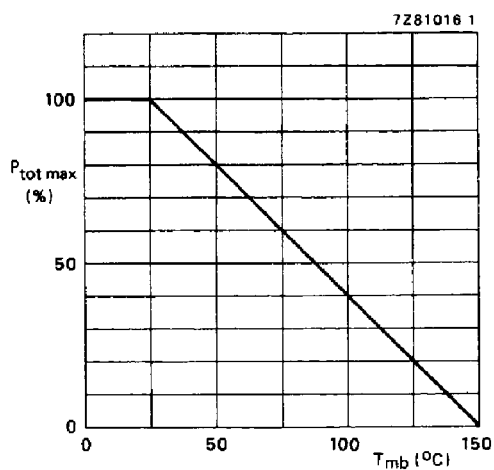
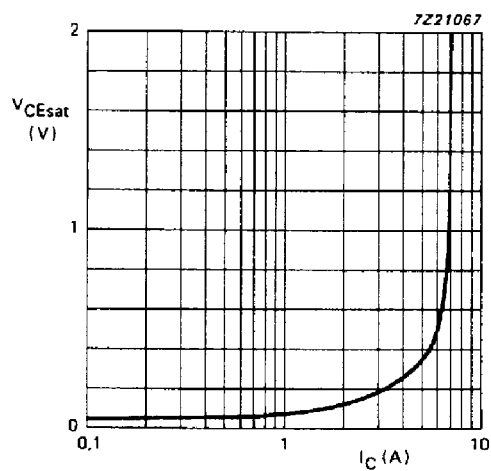
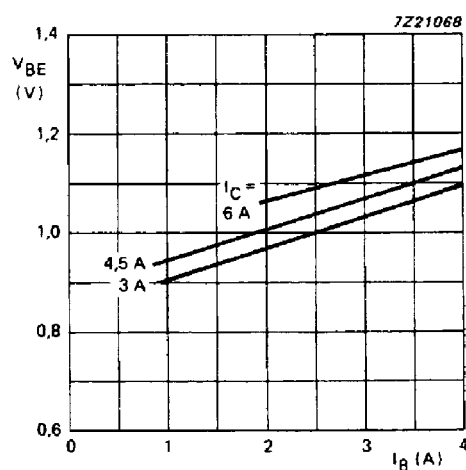


Fig. 5 Power derating curve.

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Fig. 6 Typical values $I_C/I_B = 2$; $T_j = 25\text{ °C}$.Fig. 7 Typical values base-emitter voltage at $T_j = 25\text{ °C}$.

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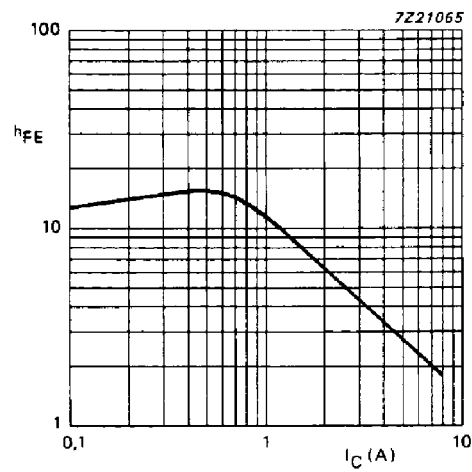


Fig. 8 Typical values DC current gain at $V_{CE} = 5$ V; $T_j = 25$ °C.

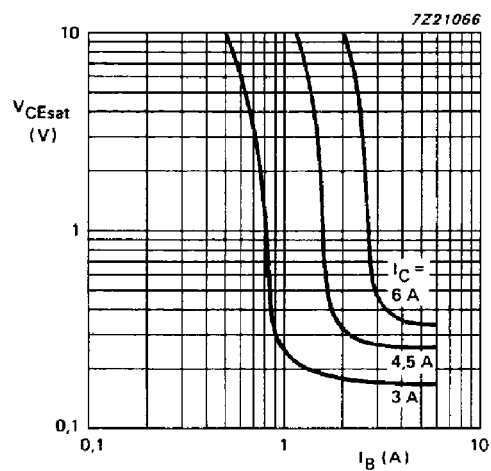
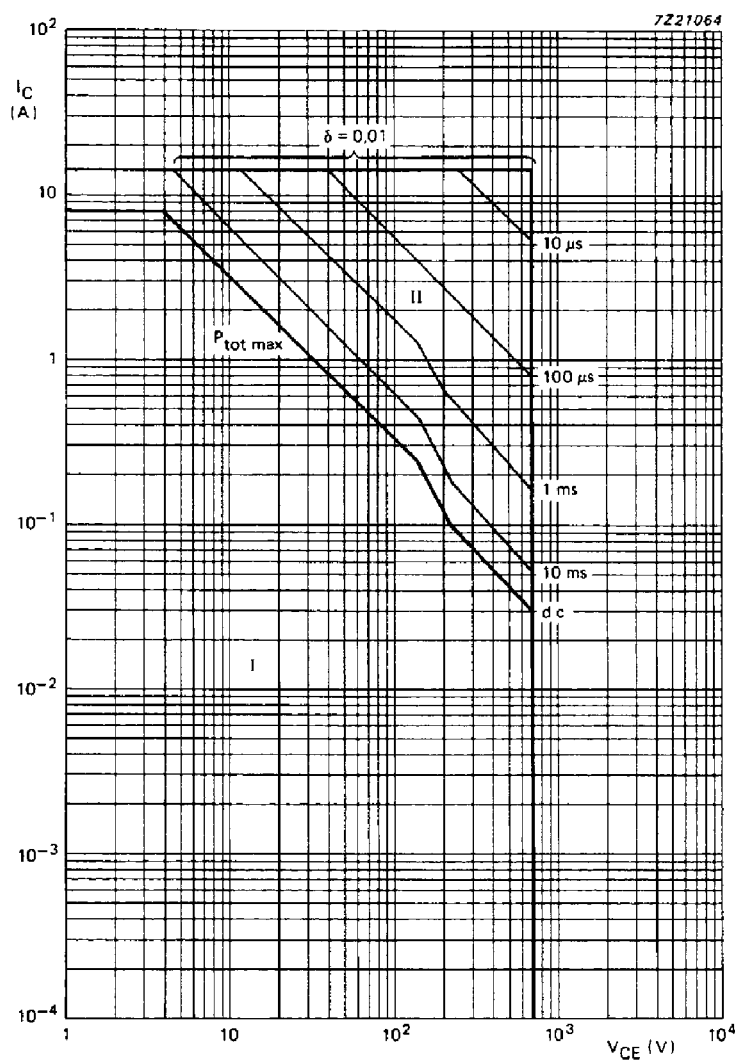


Fig. 9 Typical values collector-emitter voltage at $T_j = 25$ °C.

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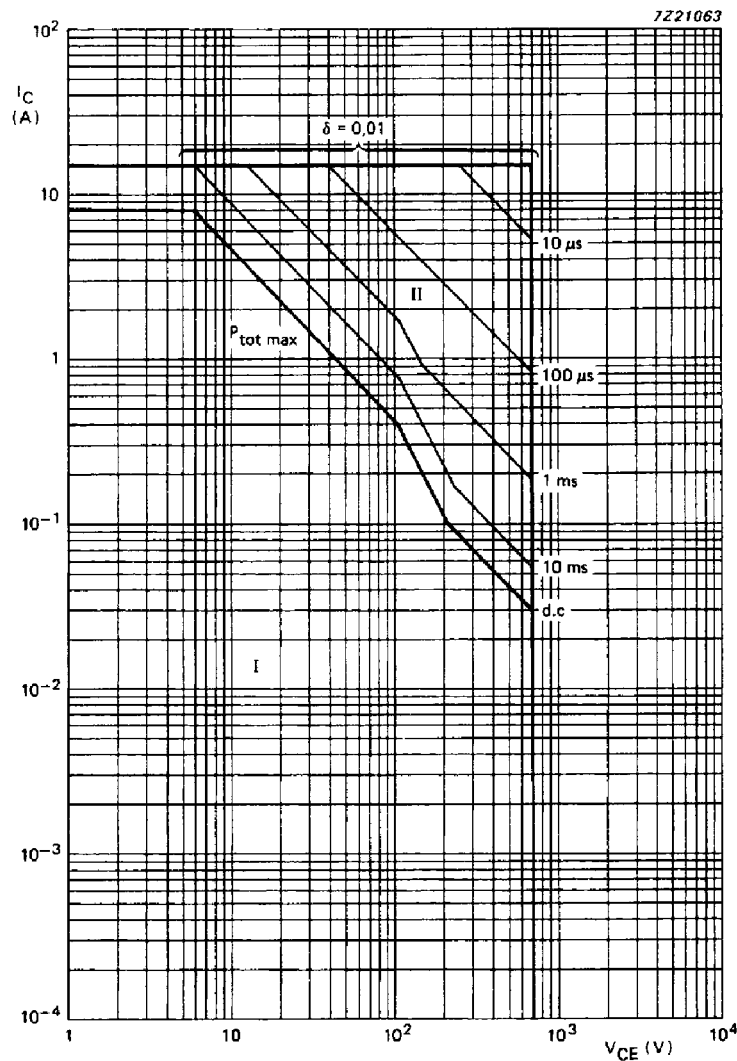


- I Region of permissible DC operation.
 II Permissible extension for repetitive pulse operation.
 Note: Mounted without heatsink compound and 30 ± 5 newtons pressure on the centre of the envelope.

Fig. 10 Safe Operating Area; $T_h = 25^\circ\text{C}$.

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I Region of permissible DC operation.

II Permissible extension for repetitive pulse operation.

Note: Mounted with heatsink compound and 30 ± 5 newtons pressure on the centre of the envelope.

Fig. 11 Safe Operating Area; $T_h = 25^\circ\text{C}$.

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